Simulation of Track Distortion due to Inhomogeneity of Electric Field in Micromegas modules

**Deb Sankar Bhattacharya** 

PhD student SINP, Kolkata & CEA Saclay WP meeting 21 January 2016, SINP, Kolkata





#### Motivation of the Study

- Developing a better understanding on Distortion
- Understanding the mis-alignment.
- Exploring scope for improvement.

# **Simulation Tool:**

Garfield Framework

>Field Solver -> neBEM

**≻Gas Transport** → Magboltz

**Primary Ionization** → Heed

► Electron Drift → Monte Carlo

# The module arrangement



Micromegas modules on the **LPTPC endplate.** 

Module size: 17 cm × 22 cm. reference frame is in r-phi system.



Module size: 3.4 cm × 3.4 cm. reference frame is Cartesian.



### Drift of electrons (Monte Carlo) at B = 1 T.



#### **Distortion comparison at B = 0 T**



Experimental observation (Thesis W. Wang) **Observation from Simulation** 





**Observation from Simulation** 

**Experimental observation** 









Due to the curve edge, there exist both Y and X component Of (distorted) electric field.

 $\mathsf{E}_{\mathsf{dist}}$ 

Non zero  $E_x$  gives rise residuals in X at B = 0T.

Х

# System used:

(1) DELL Precision T7500 Work Station/12 cores/ 72 GB RAM.(2)Xeon cluster @ 1.2 GHz/6 cores/ 16 GB RAM.

# **Thank You**

# **Backup Slides**

At the vicinity of the Module edges,

The three components of the Electric Fields are plotted in X, Y and Z

Ez:Ey:Ex

